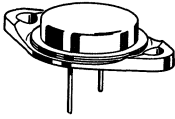


# 2N1751 (GERMANIUM)



Collector Connected to Case

**CASE 3A**  
(TO-3 modified)

PNP Germanium power transistor designed for high-current switching applications requiring low saturation voltages, short switching times and good sustaining voltage capability.

- Alloy-Diffused Epitaxial Construction
- Low Saturation Voltages –
  - $V_{CE(sat)} = 0.3 \text{ Vdc (Max) @ } I_C = 20 \text{ Adc}$
  - $V_{BE(sat)} = 0.7 \text{ Vdc (Max) @ } I_C = 20 \text{ Adc}$

## MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	$V_{CEO}$	60	Vdc
*Collector-Base Voltage	$V_{CB}$	80	Vdc
*Emitter-Base Voltage	$V_{EB}$	2.5	Vdc
*Collector Current - Continuous	$I_C$	25	A dc
Base Current - Continuous	$I_B$	5.0	A dc
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	106 1.25	Watts W/ $^\circ\text{C}$
*Operating and Storage Junction Temperature Range	$T_J, T_{stg}$	-65 to +110	$^\circ\text{C}$

## THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
*Thermal Resistance, Junction to Case	$\theta_{JC}$	0.8	$^\circ\text{C/W}$

\* Indicates JEDEC Registered Data.

**FIGURE 1 – SUSTAINING VOLTAGE TEST CIRCUIT**

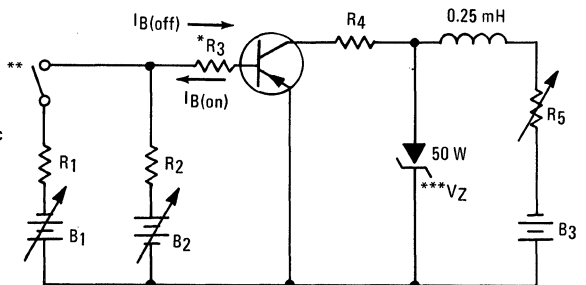
- $R_1 = 1.0 \text{ Ohm, 20 Watts}$
- $R_2 = 10. \text{ Ohms, 2.0 Watts}$
- $R_3 = 0.1 \text{ Ohm, 1.0\%}$
- $R_4 \leq 0.04 \text{ Ohm}$
- $R_5: I_C \text{ Adjust @ } V_{CE} = V_Z$
- $B_1: \text{ Adjust for } I_{B(on)} = \frac{I_C}{10}$
- $B_2 = 2.0 \text{ Vdc, Adjust for } I_{B(off)} = 0.2 \text{ Adc}$
- $B_3 = 12 \text{ Vdc}$

\*Not required if current probe is used to read  $I_B$

\*\*PRF  $\approx 60 \text{ Hz}$

\*\*\*Zener selected to establish Sustaining Voltage.

NOTE: Series impedance and inductance must be kept to a minimum.  
Adjust input pulse width for  $I_C = 25 \text{ A}$  condition.



## 2N1751 (continued)

### ELECTRICAL CHARACTERISTICS (T<sub>c</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
<b>OFF CHARACTERISTICS</b>				
Collector-Emitter Breakdown Voltage (I <sub>C</sub> = 100 mA <sub>dc</sub> , I <sub>B</sub> = 0)	V <sub>CEO</sub>	60	-	V <sub>dc</sub>
Collector-Emitter Sustaining Voltage (See Figure 1) (I <sub>C</sub> = 25 A <sub>dc</sub> )	V <sub>CE(sus)</sub>	45	-	V <sub>dc</sub>
* Floating Potential (V <sub>CB</sub> = 80 V <sub>dc</sub> , I <sub>E</sub> = 0)	V <sub>EBF</sub>	-	1.0	V <sub>dc</sub>
Collector-Emitter Cutoff Current (V <sub>CE</sub> = 80 V <sub>dc</sub> , R <sub>BE</sub> = 50 Ohms)	I <sub>CER</sub>	-	50	mA <sub>dc</sub>
Collector Cutoff Current (V <sub>CE</sub> = 80 V <sub>dc</sub> , V <sub>BE</sub> = 0)	I <sub>CES</sub>	-	5.0	mA <sub>dc</sub>
Collector Cutoff Current (V <sub>CB</sub> = 2.0 V <sub>dc</sub> , I <sub>E</sub> = 0)	I <sub>CBO1</sub>	-	200	μA <sub>dc</sub>
Collector Cutoff Current *(V <sub>CB</sub> = 80 V <sub>dc</sub> , I <sub>E</sub> = 0) (V <sub>CB</sub> = 80 V <sub>dc</sub> , I <sub>E</sub> = 0, T <sub>C</sub> = 100°C, +0, -3°C)	I <sub>CBO2</sub>	-	5.0 25	mA <sub>dc</sub>
* Emitter Cutoff Current (V <sub>EB</sub> = 2.5 V <sub>dc</sub> , I <sub>C</sub> = 0)	I <sub>EBO</sub>	-	50	mA <sub>dc</sub>

### ON CHARACTERISTICS

* DC Current Gain (I <sub>C</sub> = 20 A <sub>dc</sub> , V <sub>CE</sub> = 1.5 V <sub>dc</sub> )	h <sub>FE</sub>	30	90	-
Collector-Emitter Saturation Voltage (I <sub>C</sub> = 20 A <sub>dc</sub> , I <sub>B</sub> = 2.5 A <sub>dc</sub> )	V <sub>CE(sat)</sub>	-	0.3	V <sub>dc</sub>
Base-Emitter Saturation Voltage (I <sub>C</sub> = 20 A <sub>dc</sub> , I <sub>B</sub> = 2.5 A <sub>dc</sub> )	V <sub>BE(sat)</sub>	-	0.7	V <sub>dc</sub>

### SMALL-SIGNAL CHARACTERISTICS

* Common-Base Cutoff Frequency (I <sub>C</sub> = 0.5 A <sub>dc</sub> , V <sub>CB</sub> = 10 V <sub>dc</sub> )	f <sub>cb</sub>	1.5	-	MHz
* Small-Signal Current Gain (I <sub>C</sub> = 0.5 A <sub>dc</sub> , V <sub>CE</sub> = 6.0 V <sub>dc</sub> , f = 30 kHz)	h <sub>fe</sub>	20	-	-

### SWITCHING CHARACTERISTICS

Rise Time	(I <sub>C</sub> = 25 A <sub>dc</sub> , I <sub>B(on)</sub> = 2.5 A <sub>dc</sub> , I <sub>B(off)</sub> = 2.5 A <sub>dc</sub> ) (See Figure 2)	t <sub>r</sub>	-	12	μs
Storage Time		t <sub>s</sub>	-	10	μs
Fall Time		t <sub>f</sub>	-	8.0	μs

\*Indicates JEDEC Registered Data.

FIGURE 2 – SWITCHING TIME TEST CIRCUIT

